(FILE 'HOME' ENTERED AT 13:56:07 ON 21 APR 2003)

FILE 'USPATFULL' ENTERED AT 13:56:19 ON 21 APR 2003

SET ABBREV ON

		ET PLURAL ON
L1		(CHEMICAL ADJ3 VAPOR ADJ3 DEPOSITON OR CMP OR CHEMICAL ADJ3
M	00400 2	(CHEMICAL ADOS VAPOR ADOS DEFODITOR OR OIL OR OILLINGIE IDOS
M L2	60521 C	(CHEMICAL ADJ3 VAPOR ADJ3 DEPOSITION OR CMP OR CHEMICAL
	00331 3	(CHEMICAL ADOS VALOR ADOS DELOGITION ON ONE ON CHEMICAL
ADJ3 L3	60043 6	(CHEMICAL VAPOR DEPOSITION OR CMP OR CHEMICAL MECHANICAL
	00943 5	(CHEMICAL VAPOR DEPOSITION OR CMF OR CHEMICAL MECHANICAL
POLI	9267 8	(HEAT OR HEATED OR HEATING OR VAPORIZ? OR VAPOUR?) (10A)
L4	8267 5	(HEAT OR REALED OR REALING OR VAPORIZ: OR VAPORIZ: (10A)
(CAR	105 0	L3 AND L4
L5		(REMOV? OR ELIMINAT? OR CLEAN? OR TREAT? OR STRIP? OR
re re	360331 5	(REMOV! OR ELIMINAL! OR CLEAN! OR IREAL! OR SIRLE! OR
ETCH?)	4750 0	TC (D) 12
_ :		L6 (P) L3
L8		L7 AND L4
L9		L6 (P) L4
L10		L9 AND L3
L11	292729 S	(CHEMICAL VAPOR DEPOSITION OR CMP OR CHEMICAL MECHANICAL
POLI		-0 -00 -11
L12		L9 AND L11
		L6 AND L11
L14		L13 AND L4
L15	248264 S	(CLEAN? OR TREAT? OR WASH? OR STERILIZ? OR ETCH? OR STRIP?)
(
L16	19317 S	(HEAT OR HEATED OR HEATING OR VAPORIZ? OR VAPOUR?) (10A)
(PER		
L17		L15 (P) L16
L18	26 S	(TRIFLUOROACETIC) (5A) (PERACID)

	Туре	L #	Hits	Search Text	DBs	Time Stamp
1 `	BRS	L1	1147	cleanser or cleansed) with (chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj	DERWEN	2003/04/21 10:35
2	BRS	L2	343	treated or treatment) with (chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition) with (chamber	UB; EPO; JPO;	2003/04/21 10:12
3	BRS	L3	384	mechanical adj polishing or	US-PGP UB; EPO; JPO;	2003/04/21 10:12
4	BRS	L4	13	with (chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 10:12

	Туре	L #	Hits	Search Text	DBs	Time Stamp
5	BRS	L5	84	(inside or interior or interior adj3 wall or inner or inner adj3 wall) same ((chemical adj vapor adj deposition or CVD or CMP or	JPO; DERWEN	
6	BRS	L6	84	(treat or treating or treated or treatment) same (inside or interior or interior adj3 wall or inner or inner adj3 wall) same ((chemical adj vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition) with (chamber or equipment or container))	UB; EPO; JPO;	2003/04/21 10:15
7	BRS	L 7	7	((chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj	US-PGP UB; EPO; JPO; DERWEN	2003/04/21 10:16

	Туре	L #	Hits	Search Text	DBs	Time Stamp
8	BRS	L8	68	(etch or etching or etched or etchant) same (inside or interior or interior adj3 wall or inner or inner adj3 wall) same ((chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition) with (chamber or equipment or container))	USPAT; US-PGP UB; EPO; JPO; DERWEN	10:16
9	BRS	L9	15	(strip or stripping or stripped or stripper) same (inside or interior or interior adj3 wall or inner or inner adj3 wall) same ((chemical adj vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition) with (chamber or equipment or container))	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	
10	BRS	L10	420518	carboxylic or polycarboxylic or dicarboxylic or trifluoroacetic or TFA or tri-fluoroacetic	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 10:20
11	BRS	L11	1796	11 or 12 or 13 or 14 or 15 or 16 or 17 or 18 or 19	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	

	Туре	L #	Hits	Search Text	DBs	Time Stamp
12	BRS	L12	2	111 same 110	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 10:34
13	BRS	L13	13	111 and 110	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 10:34
14	BRS	L14	1825	cleanse or cleansed or cleanser or cleansed) with (chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or	EPO; JPO; DERWEN	2003/04/21 10:37
15	BRS	L15	527	treated or treatment) with (chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP)	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 10:37

	Туре	L #	Hits	Search Text	DBs	Time Stamp
16	BRS	L16		physical adj vapor adj deposition or post-CMP) with (chamber or equipment	US-PGP UB; EPO; JPO; DERWEN T; IBM_TD	2003/04/21 10:38
17	BRS	L17	527	treated or treatment) with (chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP)	UB; EPO;	2003/04/21 10:38
18	BRS	L18	912	(etch or etching or etched or etchant) with (chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP) with (chamber or equipment or container or apparatus)	US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B;	2003/04/21 10:38
19	BRS	L19	105	stripped or stripper) with (chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP)	UB; EPO;	2003/04/21 10:38

	Туре	L #	Hits	Search Text	DBs	Time Stamp
20	BRS	L20	115	<pre>interior adj3 wall or inner or inner adj3 wall) same ((chemical adj vapor adj</pre>	US-PGP UB; EPO; JPO; DERWEN T;	2003/04/21 10:40
21	BRS	L21	100	interior adj3 wall or inner or inner adj3 wall) same ((chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj	UB; EPO; JPO; DERWEN	2003/04/21 10:41
22	BRS	Li22	99	(etch or etching or etched or etchant) same (inside or interior or interior adj3 wall or inner or inner adj3 wall) same ((chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP) with (chamber or equipment or container or apparatus))	USPAT; US-PGP UB; EPO; JPO; DERWEN	2003/04/21 11:12

	Туре	L #	Hits	Search Text	DBs	Time Stamp
23	BRS	L23	11	(wash or washing or washed) same (inside or interior or interior adj3 wall or inner or inner adj3 wall) same ((chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP) with (chamber or equipment or container or apparatus))	USPAT; US-PGP UB; EPO; JPO;	
24	BRS	L24	26	interior adj3 wall or inner or inner adj3 wall) same ((chemical adj vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj	UB; EPO; JPO; DERWEN	
. 25	BRS	L25	242116	(remove or removing or removed or removal) with (residue or residual or contaminant or impurity or particle or film or metal adj oxide or copper adj oxide)	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	
26	BRS	L26	36401	(eliminate or eliminating or eliminated or eliminated or elimination) with (residue or residual or contaminant or impurity or particle or film or metal adj oxide or copper adj oxide)	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 10:43

	Туре	L #	Hits	Search Text	DBs	Time Stamp
27	BRS	L27	46863	(strip or stripping or stripped or stripper) with (residue or residual or contaminant or impurity or particle or film or metal adj oxide or copper adj oxide)	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 10:44
28	BRS	L28	37522	or residual or contaminant	EPO;	2003/04/21 10:44
29	BRS	L29	64570	contaminant or impurity or	JPO;	2003/04/21 12:16
30	BRS	L30	692	(125 or 126 or 127 or 128 or 129) same ((chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP) with (chamber or equipment or container or apparatus))	US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B;	2003/04/21 12:30

	Туре	L #	Hits	Search Text	DBs	Time Stamp
31	BRS	L31	0	(metal adj ligand adj complex\$3) and 130	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 10:51
32	BRS	L32	0	(metal adj ligand adj complex\$3 or ligand adj complex\$3) and 130	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:25
33	BRS	L33	1	(metal adj3 complex\$3) and 130	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 10:55
34	BRS	L34	3193	or 117 or 118 or 119 or 120 or 121 or 122 or 123 or 124)	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 11:09

	Туре	L #	Hits	Search Text	DBs	Time Stamp
35	BRS	L35	218	134 and (cleaning adj3 (gas or vapour or gaseous or vapor))	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	
36	BRS	L36	255790	(134/\$ or 148/\$ or 510/\$ or 252/\$).ccls.	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 11:11
37	BRS	L37	1	135 and 136	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 11:11
38	BRS	L38	220	deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP or treatment) with (chamber or apparatus)) with (cleaning	UB; EPO; JPO; DERWEN T; IBM_TD	2003/04/21 12:17

	Туре	L #	Hits	Search Text	DBs	Time Stamp
39	BRS	L39	1	138 and 136	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 11:54
40	BRS	L41	5372	kojima-y\$.in.	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 11:59
41	BRS	L42	1999	oshima-y\$.in.	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:15
42	BRS	L43	7368	141 or 142	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:15

	Туре	L #	Hits	Search Text	DBs	Time Stamp
43	BRS	L44	362840	125 or 126 or 127 or 129 or 128	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:16
44	BRS	L45	19729	physical adj vapor adj deposition or post-CMP or treatment) with (chamber or equipment or container or apparatus)) with (gas or	US-PGP UB; EPO; JPO;	2003/04/21 12:24
45	BRS	L46	1714	144 same 145	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:24
46	BRS	L47	21966	physical adj vapor adj deposition or post-CMP or treatment) with (chamber or equipment or container or apparatus)) with (gas or	US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B;	2003/04/21 12:27

	Туре	L #	Hits	Search Text	DBs	Time Stamp
47	BRS	L48	1862	147 same 144	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:25
48	BRS	L49	5	(metal adj ligand adj complex\$3 or ligand adj complex\$3 or metal adj complex\$3) and 148	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:32
49	BRS	L50	25579	((chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP or treatment or deposition) with (chamber or equipment or container or apparatus)) with (gas or gaseous or vapor or vapour or plasma or (cleaning adj3 (gas or vapour or gaseous or vapor))	US-PGP UB; EPO; JPO; DERWEN T:	2003/04/21 13:02
50	BRS	L51	7551	(125 or 126 or 127 or 128 or 129) same ((chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP or treatment or deposition) with (chamber or equipment or container or apparatus))	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:45

	Туре	L #	Hits	Search Text	DBs	Time Stamp
51	BRS	L53	10	152 and 136	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:33
52	BRS	L52	79	complex\$3 or ligand adj3 complex\$3 or metal adj3	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:48
53	BRS	L54	14010	(125 or 126 or 127 or 128 or 129) and ((chemical adj vapor adj deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP or treatment or deposition) with (chamber or apparatus))	LPO;	2003/04/21 12:47
54	BRS	L55	163	(metal adj3 ligand adj3 complex\$3 or ligand adj3 complex\$3 or metal adj3 complex\$3 or complexing or copper adj3 complex\$3) and 154	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:55

	Туре	L #	Hits	Search Text	DBs	Time Stamp
55	BRS	L56	27	155 and 136	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:49
56	BRS ·	L57	171	complex\$3 or ligand adj3 complex\$3 or metal adj3 complex\$3 or complexing or copper adj3 complex\$3 or chelate adj5 complex\$3 or chela\$5 adj5 complex\$3) and 154	DERWEN T;	2003/04/21 12:57
57	BRS	L58	16023	complex\$3 or ligand adj3 complex\$3 or metal adj3 complex\$3 or complexing or	DERWEN T;	2003/04/21 13:00
58	BRS	L59	34	157 AND L10	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:59

	Туре	L #	Hits	Search Text	DBs	Time Stamp
59	BRS	L60	2	158 AND L43	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 12:59
60	BRS	L62	1	deposition or vapor adj deposition or CVD or CMP or chemical adj mechanical adj polishing or PVD or physical adj vapor adj deposition or post-CMP or treatment or deposition)	EPO; JPO; DERWEN T; IBM_TD B;	2003/04/21 13:03
61	BRS	L63	7		USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 13:07
62	BRS	L61	136	complex\$3 or ligand adj3 complex\$3 or metal adj3 complex\$3 or complexing or copper adj3 complex\$3 or chelate adj5 complex\$3 or chela\$5 adj5 complex\$3) and	JPO; DERWEN	2003/04/21 13:05

	Туре	L #	Hits	Search Text	DBs	Time Stamp
63	BRS	L65	7	164 and 136	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 13:08
64	BRS	L64	172	complex\$3 or metal adj3 complex\$3 or complexing or copper adj3 complex\$3 or chelate adj5 complex\$3 or chela\$5 adj5 complex\$3) and	USPAT; US-PGP UB; EPO; JPO; DERWEN T; IBM_TD B; USOCR	2003/04/21 13:08

DERWENT-ACC-NO:

2000-148548

DERWENT-WEEK:

200027

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TITLE:

Cleaning a CVD apparatus used for

depositing oxide

ceramics on semiconductor substrates

comprises contacting

the residues with an etching medium

containing free

diketones

INVENTOR: DEHM, C; FRITSCH, E; WEINRICH, V; WENDT, H

PATENT-ASSIGNEE: SIEMENS AG[SIEI]

PRIORITY-DATA: 1998DE-1033448 (July 24, 1998)

PATENT-FAMILY:

PUB-NO

PUB-DATE

LANGUAGE

PAGES MAIN-IPC

DE 19833448 A1

February 3, 2000

N/A

006 C23F 004/00

JP 2000096241 A

April 4, 2000

N/A

006 C23C 016/44

APPLICATION-DATA:

PUB-NO

APPL-DESCRIPTOR

APPL-NO

APPL-DATE

DE 19833448A1

N/A

1998DE-1033448

July 24, 1998

JP2000096241A

N/A

1999JP-0206557

July 21, 1999

INT-CL (IPC): C23C016/44, C23F004/00, H01L021/205,

H01L021/3065

ABSTRACTED-PUB-NO: DE 19833448A

BASIC-ABSTRACT:

NOVELTY - Process for cleaning a CVD apparatus whose

04/21/2003, EAST Version: 1.03.0002

process chamber is coated with alkali(ne earth) metal-containing process residues comprises contacting the residues with an etching medium containing free diketones and reacting the diketones with the process residues forming alkaline earth metal and metal complexes.

USE - For cleaning CVD apparatus used for depositing oxide ceramics on semiconductor substrates.

ADVANTAGE - The process is simple.

CHOSEN-DRAWING: Dwg.0/2

DERWENT-CLASS: A25 A26 A97 L03 M14 U11

CPI-CODES: A12-W12B; L04-D01; M14-A;

EPI-CODES: U11-A10; U11-C09B; U11-C09F;